# IV. Basics of CCD Image Processing [v1.2.6]

### A. Overview

- The raw data acquired at the telescope is rarely of immediate use for scientific analysis
  - ♦ Need to remove unwanted/unrelated signatures
  - ♦ Need to assess uncertainties
- A significant and careful effort is made to perform these activities
  - ♦ Ideally without any loss of signal
  - ♦ And without introducing significant systematic error
- References
  - ♦ Howell, "Astronomical CCD Observing and Reduction Techniques"

### B. Removing the Bias Level

- As discussed in the *CCD Basics* lecture, the readout electronics are designed to convert a signal of 0 electrons into a non-zero count value
  - ♦ This non-zero value is always much greater than 0
  - ♦ It is referred to as the bias level
- This bias level is additive
  - Rigid shift of the zero count level
  - ♦ Therefore, it is corrected for via subtraction
  - ♦ Note: the scatter in this bias level is the Read Noise (RN)
- Frequently, the bias level varies across the detector
  - ♦ Electronics vary a little during readout
  - ♦ Therefore, it is insufficient (or at least inaccurate) to subtract a single value
  - ♦ Instead, one generates a bias image
- Generating the Bias Image [Straightforward]
  - (a) Take a series of bias images (0s exposures)
  - (b) Combine (average/median; clip cosmic rays)
  - (c) Write to disk for future use
  - (d) This image may be subtracted from other exposures to remove the bias level
- Generating the Bias Image [Overscan]
  - ♦ CCD electronics are not 100% stable
    - ▲ A series of bias images taken at some other time may not exactly give the same bias level of your science frames
    - ▲ Would prefer to assess the bias in 'real time'
  - Approach:

- ▲ Read 'fake' pixels beyond the CCD device
- ▲ There is no charge in these fake pixels
- ▲ Therefore, the values recorded give the bias level
- ▲ These values are written as the "overscan region"
- ♦ Analysis:
  - ▲ Average the values in the overscan region (along the row)
  - ▲ Fit the average values along the column
  - ▲ Generate a 2D image from this overscan fit
  - ▲ Subtract from each image
  - ▲ Write the new (bias subtracted) image to disk [as desired]

#### C. Dark Current

- Thermal motions of electrons in the CCD accumulates a spurious charge
  - ♦ The rate of this charge accumulation is referred to as the dark current
  - ♦ In many modern devices, its value is negligible
- The signal from the dark current is also additive
  - $\diamond$  But, unlike the bias, it is proportional to exposure time  $t_{\rm exp}$
  - $\diamond$  Probably linear with  $t_{\rm exp}$ , but no guarantee
- Removing the dark current
  - (a) Take a series of dark exposures at each  $t_{\rm exp}$  of interest
  - (b) Remove the bias [optional]
  - (c) Combine (clipping cosmic rays)
  - (d) Write to disk for future use
  - (e) Subtract the dark images from the science frames
- Should you measure (and subtract) the bias level separately?
  - ♦ In general, your dark images contain both bias and dark current
  - ♦ Primarily depends on whether you perform the overscan analysis

### D. Flat Fielding

- Telescope, instrument, and detector imprint unwanted signatures
  - ♦ Telescope:
    - ▲ Vignetting by the secondary, dome, etc.
    - ▲ Contributes to the so-called "illumination pattern"
  - ♦ Instrument (optics, gratings)
    - ▲ Vignetting of optics
    - ▲ Variation in throughput
    - ▲ Variations in angular magnification

- ▲ Ghosts from internal reflections
- ♦ Detector
  - ▲ Pixel-to-pixel variations in Q.E.
  - ▲ Variations in the sub-strate of the semi-conductor
- All of these effects are multiplicative
  - ♦ Not additive
  - All of the effects are relative
  - ♦ The absolute value is somewhat arbitrary (typically normalized to unity)
- Approach (combined)
  - ♦ Take a series of uniformly illuminated exposures
    - ▲ Twilight sky (wrong color)
    - ▲ Night sky (faint and not so uniform [e.g. stars])
  - ♦ Subtract detector signatures (bias, dark current)
  - ♦ Combine (remove stars, cosmic rays, etc.)
  - ♦ Normalize to a unit value
  - ♦ Divide into each science frame
- Approach: Two step
  - (a) Correct for pixel-to-pixel variations
    - ♦ Use an artificial uniform source
      - ▲ Dome screen
      - ▲ Internal mechanism
    - ♦ Normalize to unit value on large (> 100 pixel) scales
    - ♦ Divide this into each science frame
  - (b) Correct for the illumination pattern
    - ♦ On-sky illumination (night sky is optimal)
    - ♦ Observe a series of exposures
    - ♦ Subtract the detector signatures
    - ♦ Smooth over pixel-to-pixel variations
    - ♦ Normalize to a unit value
    - ♦ Divide this into each science frame

# E. Variance ( $\sigma^2$ ) Image

- For many (all?) calculations, we require an estimate of the uncertainty in our measurements
  - ♦ Simplest approach is standard propagation of error
  - ♦ i.e. simple summation of the variances
- Converting to electrons (Gain)

- For a CCD, the charge accumulated is (ideally) proportional to the photons collected
  - ▲ The photons follow Poisson statistics
  - ▲ So, too, shall the charge
- ♦ The electronics output counts which are proportional to the charge
  - $\triangle$  Gain (g) = electrons per count
- ♦ Simple conversion:
  - ▲ Multiply the *true* counts by the gain
  - ▲ True counts are those from photons (not the detector!)
  - $\land$  N = DN \* g (DN are counts or 'digital numbers')
- Detector Variance
  - ♦ Read Noise (RN)
    - ▲ Scatter associated with counting the charge
    - $\blacktriangle$  Typical variance is 10-100 electrons
    - ▲ Easily assessed from a series (or single) bias frames

$$\sigma_{\rm RN} = (RMS_{\rm counts}) g \tag{1}$$

- ♦ Dark Current (DC)
  - ▲ Poisson noise
  - $\blacktriangle$  Assume the average counts accumulated is  $DN_{\rm DC}$
  - ▲ Variance, in electrons:

$$\sigma_{\rm DC}^2 = DN_{\rm DC} g \tag{2}$$

♦ Together, the detector variance is:

$$\sigma_{\text{Detector}}^2 = \sigma_{\text{RN}}^2 + \sigma_{\text{DC}}^2 \tag{3}$$

- Source Variance
  - $\diamond$  Electrons associated with photons received:  $N_{\mathrm{source}}$ 
    - ▲ Poisson process
    - $\bullet$   $\sigma_{\text{source}}^2 = N_{\text{source}}$
- Altogether

$$\sigma_{\text{TOT}}^2 = \sigma_{\text{source}}^2 + \sigma_{\text{detector}}^2 \tag{4}$$

## F. Other (Unwanted) Issues

- Cross-talk (detector)
- Ghosts (instrument)
- Satellite trails
- Cosmic rays